


<b>Search Notes</b>  	<b>Application/Control No.</b>  10814286	<b>Applicant(s)/Patent Under Reexamination</b>  IM, HEUNG-JAE
	<b>Examiner</b>  Emmanuel Bayard	<b>Art Unit</b>  2611

SEARCHED			
Class	Subclass	Date	Examiner
375	136, 137, 142, 144, 147, 148, 150	3/28/08	EB

SEARCH NOTES		
Search Notes	Date	Examiner
East	3/28/08	EB

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
375	148, 142, 150	3/28/08	EB